Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/065,923	FUJISAKI, IWAO
Examiner	Art Unit
Russell Frejd	2128

SEARCHED						
Class	Subclass	Date	Examiner			
703	22	11.9.05	RF			
1	Z					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
TEEE/XPLORE	11.9.05	RF		
INSPEC/DIALOG				
Acm DIGITALLIB.				
SCIENCEDIRECT				
WEST				
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